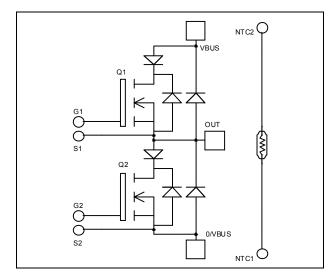
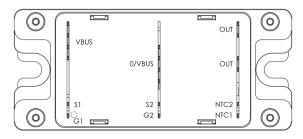


Phase leg Series & parallel diodes MOSFET Power Module

$$\begin{split} V_{DSS} &= 500 V \\ R_{DSon} &= 38 m \Omega \text{ typ } @ \text{ Tj} = 25^{\circ} C \\ I_D &= 90 A @ \text{ Tc} = 25^{\circ} C \end{split}$$





Application

- Motor control
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

Features

- Power MOS 7[®] MOSFETs
 - Low R_{DSon}
 - Low input and Miller capacitance
 - Low gate charge
 - Avalanche energy rated
 - Very rugged
- Kelvin source for easy drive
- Very low stray inductance
 - Symmetrical design
 - Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS compliant

All ratings @ $T_i = 25^{\circ}C$ unless otherwise specified

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		500	V
т	Continuous Drain Current	$T_c = 25^{\circ}C$	90	
I_{D}	Continuous Diani Current	$T_c = 80$ °C	67	A
I_{DM}	Pulsed Drain current	Pulsed Drain current		
V_{GS}	Gate - Source Voltage		±30	V
R _{DSon}	Drain - Source ON Resistance		45	mΩ
P_{D}	Maximum Power Dissipation	$T_c = 25^{\circ}C$	694	W
I_{AR}	Avalanche current (repetitive and non repetitive)		46	A
E_{AR}	Repetitive Avalanche Energy		50	m I
E_{AS}	Single Pulse Avalanche Energy		2500	mJ

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

APTM50AM38STG-Rev 7 October, 2013



Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 500V$ $T_j = 25^{\circ}C$			200	4
		$V_{GS} = 0V, V_{DS} = 400V$ $T_j = 125^{\circ}C$			1000	μΑ
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 45A$		38	45	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 5mA$	3		5	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±200	nA

Dynamic Characteristics

•	Characteristic Characteristic	Test Conditions	Min	Тур	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$		11.2		
C_{oss}	Output Capacitance	$V_{DS} = 25V$		2.4		nF
C_{rss}	Reverse Transfer Capacitance	f=1MHz		0.18		
Q_{g}	Total gate Charge	$V_{GS} = 10V$		246		
Q_{gs}	Gate – Source Charge	$V_{\text{Bus}} = 250V$		66		nC
Q_{gd}	Gate – Drain Charge	$I_D = 90A$		130		
$T_{d(on)}$	Turn-on Delay Time	Inductive switching @ 125°C		18		
$T_{\rm r}$	Rise Time	$V_{GS} = 15V$ $V_{Bus} = 333V$ $I_D = 90A$		35		
$T_{d(off)}$	Turn-off Delay Time			87		ns
T_{f}	Fall Time	$R_G = 2\Omega$		77		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		1510		т
E_{off}	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 333V$ $I_D = 90A, R_G = 2\Omega$		1452		μJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15V, V_{Bus} = 333V$ $I_D = 90A, R_G = 2\Omega$		2482		T
E _{off}	Turn-off Switching Energy			1692		μJ
R_{thJC}	Junction to Case Thermal Resistance				0.18	°C/W

Series diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage	;		600			V
I_{RM}	Maximum Reverse Leakage Current	$V_R=600V$				250	μΑ
I_F	DC Forward Current		$T_c = 80^{\circ}C$		90		A
	Diode Forward Voltage	$I_F = 90A$		1.6 1.		1.8	
V_{F}		$I_F = 180A$			1.9		V
		$I_F = 90A$	$T_j = 125$ °C		1.4		
4	Reverse Recovery Time		$T_j = 25$ °C		85		ng
t_{rr}		$I_F = 90A$ $V_R = 400V$	$T_{j} = 125^{\circ}C$		160		ns
Q _{rr}	Reverse Recovery Charge	$di/dt = 600A/\mu s$	$T_j = 25^{\circ}C$		390		nC
			$T_j = 125$ °C		2100		IIC
R_{thJC}	Junction to Case Thermal Resistance					0.45	°C/W

APTM50AM38STG-Rev 7 October, 2013



Parallel diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
I_{RM}	Maximum Reverse Leakage Current	$V_{R} = 600V$				250	μA
I_{F}	DC Forward Current		$T_c = 90$ °C		90		A
	Diode Forward Voltage	$I_F = 90A$			1.8	2.2	
V_{F}		$I_{\rm F} = 180A$			2		V
		$I_F = 90A$	$T_{j} = 125^{\circ}C$		1.3		
_	Reverse Recovery Time		$T_j = 25$ °C		25		
t_{rr}		$I_F = 90A$ $V_R = 400V$	$T_j = 125$ °C		160		ns
Qrr	Reverse Recovery Charge	$di/dt = 600 \text{A/}\mu\text{s}$	$T_j = 25^{\circ}C$		105		nC
		•	$T_j = 125^{\circ}C$		1440		IIC
R_{thJC}	Junction to Case Thermal Resistance					0.45	°C/W

Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit	
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V	
T_{J}	Operating junction temperature range			-40	150		
T_{JOP}	Recommended junction temperature under switching conditions			-40	T _J max -25	°C	
T_{STG}	Storage Temperature Range			-40	125	C	
$T_{\rm C}$	Operating Case Temperature			-40	100		
Torque	Mounting torque	To Heatsink	Γo Heatsink M5		4.7	N.m	
Wt	Package Weight		•		160	g	

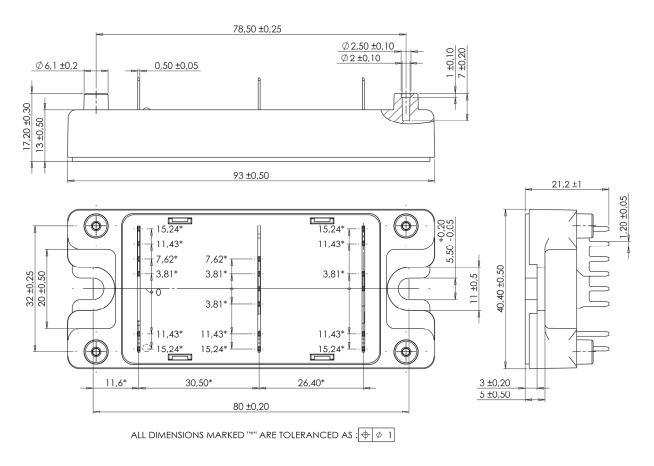
Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic	,	Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B _{25/85}	$T_{25} = 298.15 \text{ K}$			3952		K
ΔΒ/Β		T _C =100°C		4		%

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature R_T: Thermistor value at T



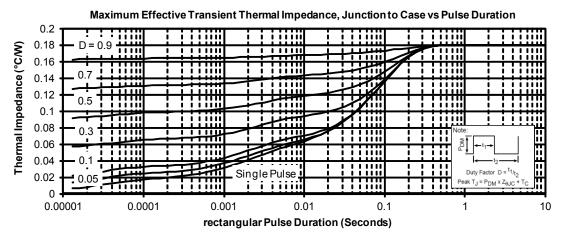
SP4 Package outline (dimensions in mm)

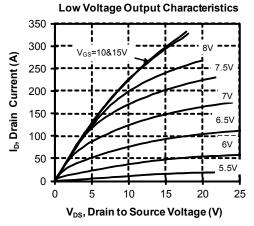


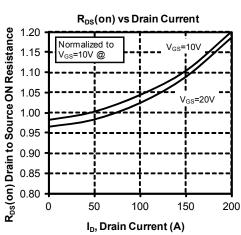
See application note APT0501 - Mounting Instructions for SP4 Power Modules on www.microsemi.com

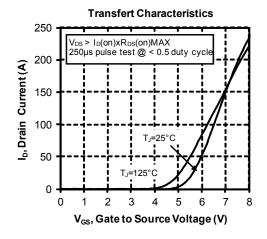


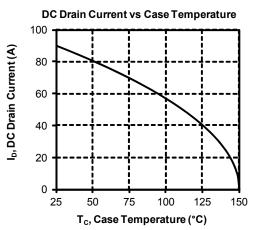
Typical Performance Curve



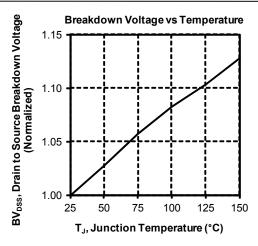


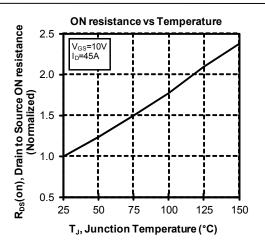


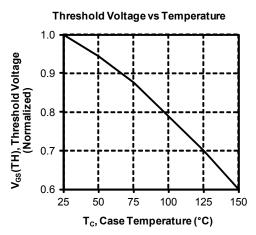




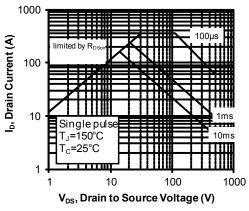


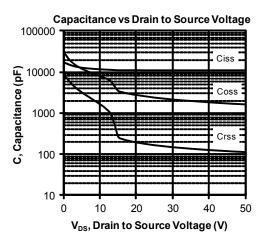


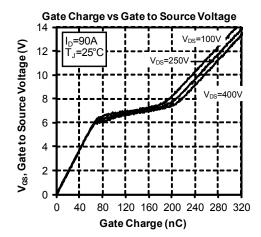




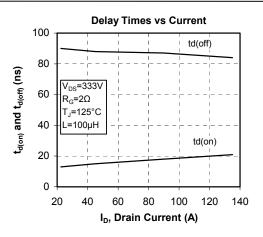


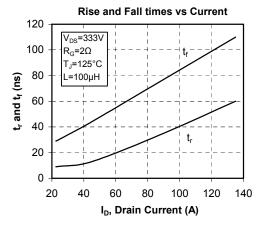


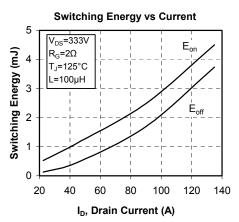


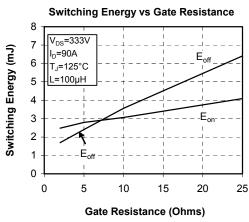


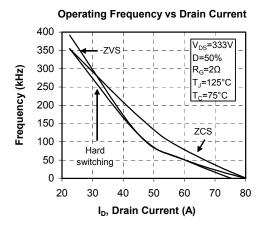


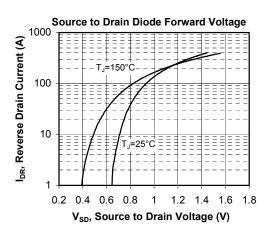














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APTM50AM38STG - Rev 7 October, 2013